Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/775,660	CHEN ET AL.	
Examiner	Art Unit	
Callie E. Shosho	1714	

	SEAR	CHED	
Class	Subclass	Date	Examiner
523	160		
	161		
		1/31/2006	cs
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST-searched key words (see attached sheets)	1/31/2006	cs
523/160 523/161 524/589 524/590 106/31.6 106/31.85 - (text searched - see attached sheets)	1/31/2006	cs